Optical properties of nanocrystalline Y 20 3 E u 3+

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Abstract

Optical properties of nanocrystalline red-em itting phosphor, Europium doped Yttria $(Y_2O_3 \pm u^{3+})$, of average particle size 15 nm are investigated. The intensity of the strongest em ission line at 612 nm is found to be highest in the nanocrystalline sample with 4 at. wt. % of Europium. The narrow electronic em ission spectrum suggests a crystalline surrounding in this nanom aterial. We have estimated the strength of the crystal eld parameter at the dopant site, which plays a crucial role in determining the appearance of the intense em ission line. The equilibrium temperature of this system has also been calculated from the intensity ratio of Stokes and anti-Stokes Ram an scattering. Though known for the bulk samples, our approach and consequent results on the crystalline nanom aterial of $Y_2O_3 \pm u^{3+}$ provide a unique report, which, we believe, can be of considerable signicance in nanotechnology.

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I. INTRODUCTION

The optical properties of rare-earth ions trapped in inorganic oxides continue to be a research attraction in terms of both their fundamental and technological importance. Yttrium oxide doped with Eu3+ is one of the main red-emitting phosphors and is widely used in lighting industry and in solid-state-laser based devices. The unique optical properties of this material is based on the f- and delectrons of Europium ions. To enhance the brightness and resolution of displays in devices in the present nanotechnology regime, it is important to develop phosphors with controlled morphology and small particle size (nanoparticles). The potential of this low dimensional material in fabrication of modern micro/nano devices requires an understanding of their fundamental properties in detail. In particular, the origin and behavior of the strongest 5D_0 7F_2 transition spectrum from Eu3+ needs to be investigated because of its importance in designing laser devices. For example, permanent laser-induced gratings have been fabricated using crossed write beams in resonance with the 7F_2 5D_0 absorption transition of Eu3+.6

O ver the last couple of decades, a considerable am ount of work on the spectral properties of bulk $Y_2O_3 \pm u^{3+}$ has been reported in the literature. 7,8,9,10,11,12,13,14,15 . Additionally, we not several articles on nanoparticles of this material, though, the detailed study of their optical properties is, as far as we are aware, incomplete. In recent times, Schmechel et al. have reported luminescence properties of nanocrystalline $Y_2O_3 \pm u^{3+}$. However, due to the presence of defect/disordered states in this low dimensional system, the quantum e ciency of this nanomaterial is much less than the corresponding bulk commercial sample. Furthermore, Konard et al. have synthesized and studied the luminescence properties of $Y_2O_3 \pm u^{3+}$ nanoparticles, though they do not discuss the quantum eciency of this material. In both these studies 16,17 one does not not the details of the optical emission spectrum of this low dimensional system.

A part from optical properties, other characteristics of such inorganic, lanthanide-doped oxides also play an important role in using these materials in technology. Walsh et al. have recently demonstrated that the strength of the crystal eld is crucial in improving the performance of solid-state lanthanide lasers. It may be noted that the doped Europium ions in these oxides provide the high-energy local mode phonons, which can produce structural modication of the host. Finally, the knowledge on the thermal properties of this material is

required for e cient laser operation (for example, thermal lensing) as well as the stability of laser-induced gratings. Such gratings, designed from Europium ion doped glasses, are found to be stable up to a certain equilibrium temperature, but get erased with rising thermal energy.⁶

In this article, we have addressed optical properties of nanocrystalline Europium doped Y ttria, prepared by soft chem ical route. Section II covers the sample preparation and characterization of the nanomaterial by x-ray directometry and Transmission Electron microscopy (TEM). In Section III, we have reported the electronic emission spectrum for the range of 490 nm -900 nm by Photolum inescence spectroscopy. The crystal elde ect and equilibrium temperature in the nanocrystalline Y $_2$ O $_3$ Eu $^{3+}$ have been discussed in Section IV . Finally, in Section V we have sum marized our results with a few concluding remarks.

II. SAMPLE PREPARATION AND CHARCTERIZATION

The nanomaterial has been prepared by soft-chemical method using TEA (Triethanolamine) as complexing (chelating) agent. Solid powder of Europium Oxide and Yttrium Oxide (both from ALDRICH) are boiled with concentrated nitric acid in water bath to get clear solutions of Europium Nitrate and Yttrium Nitrate, respectively. The addition of nitric acid is continued until the solution reached a pH of 3.0. Europium Nitrate and Yttrium Nitrate solutions are taken in di erent stoichiometric ratios in order to vary the Eu3+ concentration by 1-7 at. wt. with respect to Y3+. These nitrate solutions and TEA are taken in a beaker and then heated on a hot plate at a tem perature of about 180-200 C.TEA helps to keep the metal ions in homogenous solution through the reaction without precipitation. Due to complete dehydration of the complex precursor and decomposition of the metal complexes upon heating the mixture, we get a uy mass. It is calcined at 900 C for four hours. A white powder is obtained. In the rest of this article, we denote the nanomaterial of Y_2O_3 doped with 4 at. wt. Eu3+ (in stoichiometric ratio) as Sample A. The micron-sized particles (Sample B) are prepared by heating a part of the above sample at 1200 C for six hours, after which white bulk Y_2O_3 Eu3+ phosphor is obtained.

Sam ples for Transm ission E lectron M icroscopy are deposited onto 300 m esh copper TEM grids coated with 50 nm carbon lms. Nanocrystals, dissolved in Acetone, are placed on the grid drop-wise. The excess liquid is allowed to evaporate in air. The grids are examined in

JEOL 2010 m icroscope with U ltra-H igh R esolution (UHR) pole-piece using a LaB $_6$ lament operated at 200 kV. The high resolution transm ission electron m icroscopy (HRTEM) in age for Sam ple A, shown in Fig. 1(a), clearly demonstrates the lattice fringes for the cubic phase of Y $_2$ O $_3$: Eu $^{3+}$. From the micrograph we have determined the lattice spacing in the particle to be 0.29 nm, which corresponds to (222) plane of cubic phase of this material. The frequency plot of the size distribution, shown in Fig. 1(b), is obtained by measuring the size of many particles per sample. Size distribution for the nanoparticles are usually found to be log-norm al $_2^{20}$

$$P(d) = \frac{1}{d^{2}} \exp \frac{\ln^{2}(d=d)!}{2^{2}} :$$
 (1)

Here d and are related to the average size and the size distribution of the particles. By tting the frequency plot using Eq. (1) [solid line in Fig. 1 (b)], the average particle size of Sample A has been estimated to be 15 nm with a very narrow size distribution (= 0.14). The average particle size of Sample B is found to be 500 nm with a wider size distribution.

Sam ples have been characterized by x-ray di raction at room temperature using Philips PW 1710 X-ray Di ractom eter, equipped with a vertical goniom eter and CuK radiation source of wavelength (=1.514 A).X-ray di raction patterns for both Sam ple A and B are shown in Fig. 2. The observed values of the di raction angles (2) m atch quite well with the reported data and the patterns exhibit cubic symmetry (space group Ia3). Identical di raction patterns of both Sam ple A and Sam ple B indicate that the lattice constants in both the materials are same i.e. there is no distortion in the structure of Sam ple A because of lowering of dimension of the system. We have calculated the average nanocrystallite size (L) using Scherrer's equation 122

$$=\frac{0.94}{1.\cos i};$$
 (2)

where (expressed in radians) is the full width at the half maxima (FW HM) of the x-ray di raction peak. is the di raction peak position. Taking the di raction resolution function (DRF) to be Gaussian and the di raction line to be Lorentzian, the line-width correction for the x-ray instrumental broadening can be taken into account by using the empirical expression²³

$$= e^{\frac{1}{e}};$$
 (3)

where, = 1 0:1107= $_{\rm e}$. $_{\rm e}$ is the ratio of observed FW HM ($_{\rm e}$) and the FW HM ($_{\rm d}$) of the DRF, whereas, is the ratio of the true FW HM () of the di raction line and $_{\rm d}$. For our instrument $_{\rm d}$ = 0.10. For the di raction peak at 2 = 28.974 of the Sample A, $_{\rm e}$ = 0.326, which gives = 0.254. From Eq. (2), the crystallite size has been estimated, which is close to what we have observed from the HRTEM in ages of the particles, discussed earlier. The narrow di raction pattern from the nanoparticles in plies the crystalline nature of Sample A.

III. OPTICAL EM ISSION SPECTRA

Lum inescence spectra are obtained using a 1200 g/m m holographic grating, a holographic supernotch lter, and a Peltier cooled CCD detector. We use a 488 nm Argon ion laser as our excitation source.

The electronic transition spectra for the range 490 nm to 900 nm are shown in Fig. 3. M any of these transitions satisfy the magnetic dipole selection rules (J = 0, 1 with J = 0 \sharp J⁰ = 0) in an intermediate coupling scheme (shown in Fig. 4). In free Eu³⁺, the 5D_0 7F_2 transition is forbidden (for both magnetic and electric dipoles). This holds true in a crystalline environment, which has inversion symmetry. It is well established that in the body centred cubic structure of Y ttria, E u3+ replaces Y3+ in two di erent sites. 75% of these sites are with C $_2$ and the other 25% are with S $_6$ sym m etry. Between these two the form er does not have the inversion sym m etry. 25,26,27,28,29 A coording to the theory of Judd 30 and 0 felt 31 the 5 D $_0$ 7 F $_2$ transition becomes electric dipole type, due to an admixture of opposite parity 4fⁿ ¹ 5d states by an odd parity crystal eld component. 5 D $_0$ 7 F $_{3;5}$ transitions have a mixed character - magnetic dipole intensity usually to rst order and electric dipole intensity to second order. The 5 D $_0$ 7 F $_3$ transition exhibits a relatively larger intensity than what is expected because of its large induced electric dipole character. The large oscillator strength of the 5 D $_0$ 7 F $_3$ transition m ay be attributed to signicant crystaleeld induced mixing of the 7 F $_3$ state to 7F_2 state, leading to the transfer of energy from 5D_0 7F_2 to 5D_0 7F_3 transition. 33 5 D $_{0}$ 7 F $_{4;6}$ transitions are electric dipole in character and have appreciable intensities. 32 The

magnetic dipole and electric quadrupole transitions are forbidden for J_0 J_0 line. The theory of Judd and 0 felt does not explain the 5D_0 7F_0 uorescence of Eu $^{3+}$ ion because the J_0 J_0 transition is forbidden even in the presence of non-centrosymm etric potential. The origin of this em ission line may be explained by the variation in crystal eld potential, which causes the mixing of odd parity J=1 states into the 7F_0 and 5D_0 states. How ever, from the uorescence line-narrowing experiment, it has been shown that the 5D_0 7F_0 borrows its intensity from 5D_0 7F_2 line through the J-mixing in this material. Other than the above transitions, direct band to band transition and excitonic emission appear at 6.2 eV 36 and 5.9 eV 36 , respectively, in this system. We could not study these emission lines because of our experimental limitations (recall that we have used 488 nm as the wavelength of our excitation source). No bands are reported below 490 nm. However, electronic transitions from 5D_3 to 7F_J is known to occur in this region. In Fig. 4 we have shown the energy level diagram of the low-lying states of the Eu $^{3+}$ ion in nanocrystalline Y_2O_3 Eu $^{3+}$, as obtained in our experiment.

It is well known that a strong energy transfer takes place from S₆ to C₂ site, which gets stronger with increase in Europium content. To onsequently, the ratio of the emission intensity of C₂ site to the emission intensity of S₆ site also increases with increase in Europium concentration in the sample.34 Previous emission study on cubic bulk Y 20 3 E u3+ has shown that only the transitions 5D_0 7F_1 originate from S_6 site, 38,39 whereas nearly all of the other features in the electronic spectrum are due to Eu^{3+} ion in C_2 sites. The di erent behaviour of Eu^{+3} ion in two dierent lattice sites is most probably due to the large diameter (0.95 A) of Eu^{3+} ion, which Ils the lattice sites of the host, and gets a exted by nearby atom s. Fig. 5 shows the change in ratio of the peak intensities of emission spectra for 5D_0 (581) nm) transition of C_2 site and 5D_0 7F_1 transitions (587 nm) of S_6 site for nanocrystalline $Y_2O_3 \pm u^{3+}$ with dierent Europium ion concentration. Due to the energy transfer from S_6 site to C2 site, the ratio increases till the dopant concentration is 4 at. wt. % of the host m aterial, but decreases with further increase in mole concentration of Europium ion. This drop in the ratio with concentration of Eu3+ beyond 4 at. wt. % can be attributed to uorescence quenching, which arises due to the energy transfer or electron transfer process between the two nearest excited Eu3+ and dominates over the spontaneous emission process.40 In the above analysis we have compared ⁵D₀ ⁷F₁ transition of S₆ site with ⁵D₀ ⁷F₀ transition of C₂ site, as these two lines are of comparable intensity. Justifying the above discussion,

we now show that the e ect of uorescence quenching becomes dominant in the case of the most intense emission line at 612 nm for the sample doped with more than 4 at. wt. % of Eu^{3+} . We have tred the emission spectrum at 612 nm for all the samples with Lorentzian line shape. In the inset of Fig. 5 we have shown the variation in intensity of this emission spectrum with concentration of Eu^{3+} in nanocrystalline Y_2O_3 . The sample with 4 at. wt. % of dopant concentration (Sample A) shows highest emission intensity for 612 nm transition line. Hence, we have taken this particular material as a standard nanocrystalline sample and compared its physical properties with bulk (Y_2O_3 Eu^{3+}).

In Fig. 6, we have compared the most intense electronic transition line at 612 nm in the spectra for both nanomaterial (dashed-dotted line: Sample A) and the bulk system (solid line: Sample B). Both the spectra have been tted with three Lorentzian line shapes. In the non-linear least square the width of the spectral line and its intensity have been kept as varying param eters. We have not observed any shift in the lum inescence peak position due to quantum size e ect. As shown in Fig. 6, the lum inescence intensity of 612 nm transition from Sample A is slightly less than that observed in Sample B. Surface states are the sources of non-radiative recombination centers. Due to high surface to volume ratio in nanoparticles compared to the corresponding bulk material the non-radiative recombination processes dom inate in the former. Moreover, there is a possibility of absorption by im purities in nanostructured materials. These, in turn, decrease the lum inescence e ciency in nanoparticles. 16 However, here we would like to point out that the drop in intensity in nanocrystalline sample compared to the corresponding bulk material, prepared by us, is much less than what has been reported before in the literature, 16 due to the absence of im purities and defects in Sample A (as we have observed from our x-ray measurements). We note that (i) the half-widths of the 612 nm line for sample A and sample B have been obtained as 0.5 0.2 nm and 0.4 0.2 nm, respectively. The sharp transition spectrum for Sample A suggests nearly crystalline surrounding and (ii) the appearance of all lines from 5 D $_2$ and 5 D $_1$ signify absence of too m any non-radiative cross-relaxation processes in Sam ple Α.

IV. CRYSTAL FIELD EFFECT AND EQUILIBRIUM TEMPERATURE

The most intense forced electric dipole 5D_0 7F_2 transition line, discussed in the previous section, is expected to be hypersensitive to the crystal eld at the dopant site. The crystal eld H am iltonian can be written as 41

$$H_{CF} = X X B_{lm} C_{lm} (i; i);$$
(4)

where B $_{\rm lm}$, the crystal eld parameter, which describes the e ect of the crystal eld on the free ion H am iltonian, satis es

$$B_{lm} = (1)^m B_{l;m}$$
 (5)

and $C_{\,\mathrm{lm}}$ are spherical tensors de ned in terms of spherical harm onics according to

$$C_{lm}$$
 (i) = $\frac{4}{2l+1}$ Y_{lm} (i; i): (6)

In Eq. (4) - (6) l runs over 2, 4, 6..... and m = 0, 2, 4..... l. The sum on i runs over the number of electrons in the 4f on quration. i and i are the angular coordinates of the ith electron. The reason for the presence of only even lin the sum is related to the fact that even 1 terms in the expansion of Eq. (4) contribute to the shifting and splitting of energy levels. On the other hand, the odd 1 terms in Eq. (4), if included, would represent the mixing of opposite parity states from higher lying con guration into the 4f one. The usual analysis with the crystal eld potential, in Eq. (4), does not take into account the m ixing of di erent J-states. 1=0 is always ignored because it corresponds to spherically sym m etric crystal eld that shifts all energy levels equally without a ecting the energy level splitting. However, as discussed before, J-m ixing plays an important role in explaining the optical emission spectrum of the material. Assuming that the D₀ F₀ transition is allowed only by J-m ixing, the intensity variation of $^5\mathrm{D}_{\,0}$ $^7\mathrm{F}_{\,0}$ line is ascribed to the e ect of m ixing of ⁷F₂ into ⁷F₀ states. This can be taken into account by considering the second-order term (crystal eld parameter B_{20}) in the above local eld potential. The transition strength of ${}^5\mathrm{D}_0$ ${}^7\mathrm{F}_0$ line is known to be proportional to B_{20}^2 , where = 4=75 $_{20}$ and that of 5 D $_0$ 7 F $_2$ line is independent of B $_{20}$. Here, $_{20}$ is the energy separation between the 7 F $_2$ and 7F_0 states. Thus, the intensity ratio of 5D_0 7F_0 and 5D_0 7F_2 transitions is given by

$$\frac{I_{0\ 0}}{I_{0\ 2}} = \frac{4B_{20}^{2}}{75_{20}^{2}} : \tag{7}$$

Taking $_{20} = 900$ cm 1 , variation of crystal eld param eter, B_{20} , with increase in concentration of Eu⁺³ is shown in Fig. 7. Its value for Sample A and Sample B are estimated to be 1077 cm 1 and 995 cm 1 , respectively. These values of B_{20} are found to be in good agreement with the reported value 1260 cm 1 for the commercial bulk system 35 Indirectly, it also reveals that the crystal elde ect is similar in both Sample A and Sample B and match very well with the commercial bulk material.

Fig. 8 shows both Stokes and anti-Stokes side of the Ram an line at 375 cm 1 , typical of cubic Y $_{2}$ O $_{3}$ \pm u $^{3+}$ lattice. Local heating produced by the vibrational modes can give rise to a change in structure of the local environment of the \pm u $^{3+}$ by causing ions to move from one equilibrium position to another. Stokes (I_{S}) and anti-Stokes(I_{AS}) Ram an scattering intensities are related to a very good approximation by the relation 42

$$n(!)I_{S} = [n(!) + 1]I_{AS};$$
 (8)

where n (!) is the Bose-E instein therm alfactor, explicitly given by

$$n(!) = \frac{1}{\exp(h! = k_B T) - 1};$$
 (9)

where k_B is Boltzm ann's constant and T is the equilibrium temperature of the sample. From the intensity ratio of the Stokes (I_s) and anti-Stokes (I_{AS}) Ram an line one can calculate the equilibrium temperature (T) of the material by using the equation⁴²

$$\frac{I_{S}}{I_{AS}} = \exp \left(\frac{h!}{k_{R}T}\right)! \tag{10}$$

where, ! is the phonon frequency. We have the both Stokes and anti-Stokes Raman spectra from the sample with Lorentzian line shape. In the non-linear least square the intensity, width, and the peak position have been kept as thing parameters. From the intensity ratios of the Stokes and anti-Stokes Raman lines and using Eq. (10), the equilibrium temperatures of Sample A and Sample B have been estimated to be 247 K and 257 K, respectively. In other words, the material is stable till its equilibrium temperature is within this value. The equilibrium energy $(k_{\rm B}\, {\rm T})$ of a system is a thermodynamic property. Thus, we expect both Sample A and Sample B to have an equivalent local environment, which

again is an important fact to be kept in m ind while using these nanocrystalline $Y_2O_3 \pm u^{3+}$ in nanotechnology.

V. CONCLUSION

In this article, we have reported optical properties of cubic nanocrystalline rare-earth doped inorganic oxide, $Y_2O_3 \pm u^{3+}$, of average particle size 15 nm. The electronic energy levels of this material are obtained from the photolum inescence measurements. The analysis of the variation in intensity of the lum inescence spectrum at 612 nm for nanocrystalline $Y_2O_3 \pm u^{3+}$ as a function of Eu^{3+} concentration in the host lattice leads to the observed fact that the dopant concentration of 4 at. wt% exhibits maximum intensity of the emission peak. We have discussed the crystalline nature of the material and the local elde ect around the Europium ion, both of which in the local eld at the dopant site, has been estimated from the intensity ratio of Stokes and anti-Stokes Raman line. Table 1 summarizes the physical properties of the nanocrystalline $Y_2O_3 \pm u^{3+}$, doped with 4 at. wt.% of Eu^{+3} (Sample A), as obtained in our experiment and analysis. We claim that such nanocrystalline rare-earth doped oxides, with known characteristics can be used commercially as a red-emitting phosphor in nanotechnology.

A cknow ledgem ent

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Figure Captions

Fig. 1. (a) HRTEM image of Sample A and (b) the frequency plot.

Fig. 2. X -ray di raction pattern for Sample A (dotted line) and Sample B (solid line).

Fig. 3. Em ission spectrum of nanocrystalline $Y_2O_3 \pm u^{3+}$ for exc = 488 nm. Intensities of (a) and (b) are not in the same scale.

Fig. 4. A schem atic diagram of the energy level of E u^{3+} in nanocrystalline Y $_2{\rm O}$ $_3$ E u^{3+} .

Fig. 5. Filled squares are the variation of the ratio of the intensities of 5D_0 7F_0 to 5D_0 7F_1 em ission spectrum with at wt. % of Eu ion in nanocrystalline Y_2O_3 Eu^{3+} . The solid line is the guide to the eye. The variation in intensity for 5D_0 7F_2 em ission peak with dopant concentration is shown in the inset.

Fig. 6. Em ission spectrum of 612 nm line for bulk (solid line) and nanocrystalline (dashed-dotted line) of $Y_2O_3 \pm u^{3+}$. The non-linear tof the data for Sample A is shown in the inset.

Fig. 7. Variation of B $_{20}$ with concentration of Eu ion.

Fig. 8. Stokes and anti-Stokes R am an spectra for Y_2O_3 : E u^{3+} . The squares are experimental data points. The solid lines are non-linear least square—t to the data.

TABLE I:Physical properties of nanocrystalline Y $_2\text{O}$ $_3$ $\pm\,\text{u}^{3+}$

P roperty	R em ark
Size of the particle	15 nm
Size distribution	5 nm
Phase	Cubic (corresponds to space group Ia3)
Intensity of the strongest em ission line	Maximum for 4 at. wt. % doped Eu ³⁺ ion
at 612 nm	
C rystal eld param eter (B $_{20}$)	1077 cm $^{\mathrm{1}}$
Equilibrium temperature	247 K